

## 7.1 Configure Crystal Trim

Test	Comment
Description	Trim out the initial tolerance of the crystal. This is an absolute requirement when testing BlueCore modules. Once determined, the trim value is written to the PS key.
Equipment Requirements	<p>Spectrum analyser capable of measuring at the 2.4GHz band. The following settings are used:</p> <ul style="list-style-type: none"> <li>Video band width (VBW) 10kHz</li> <li>Resolution band width (RBW) 10kHz</li> <li>Span 1MHz</li> <li>Sweep time 27.5ms</li> </ul> <p>Personal computer (PC) with UART/USB links to device under test.</p>
Method	<p>Set-up spectrum analyser</p> <p>Open host connection to BlueCore module</p> <p>Use CFG_XTAL_FTRIM to set the trim value to 0 (zero)</p> <p>Start TXSTART at frequency 2441MHz. This is the wanted frequency</p> <p>Read initial frequency from the spectrum analyser (use "peak search"). Determine the frequency offset.</p>
Software Requirement	Host side software with CSR's manufacturer's extension command set implemented
Coverage	<p>Pullability of the crystal</p> <p>Resolution of the capacitor digital to analogue converter (DAC)</p> <p>Tank capacitors fitting</p> <p>Crystal circuit</p> <p>Crystal drive circuit fault</p> <p>PS key PSKEY_ANA_FREQ (0x01fe)</p>
Test Times	<p>Brute force approach – 12.34s with a SD of 0.076s</p> <p>Search approach – 5.13s with a SD of 0.056s</p>

Table 7.1: Configure Crystal Trim Test

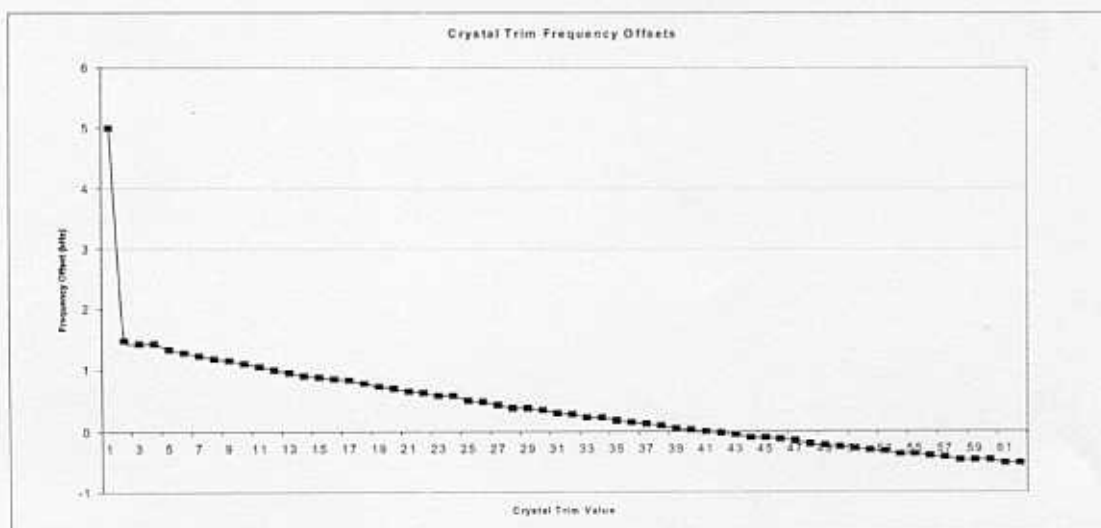


Figure 7.1: Typical Crystal Trim Test Output For Module